Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/757,707	DE LAMEILLIEURE, JAN L.P.
Examiner	Art Unit
Y Lee	2621

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	240.01 240.02 240.12 240.21	7/5/2006	YL
	240.25		
	240.26		
	240.27		
H04N	7/12		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
375	240.26	7/6/2006	YL
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(INCLUDING SEARCH STRATEGY)				
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